Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/552,339	HUFFMAN, DAVID C.	
Examiner	Art Unit	

3752

Steven J. Ganey

SEARCHED					
Class	Subclass	Date	Examiner		
239	106,114 123,290 296,433 434,583				
	390,600	12/1407	87		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text and inventorship searched.	Ideus	E		
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